Application No.: 10/527,743

Docket No.: SON-2814

AMENDMENTS TO THE CLAIMS

Please amend the Claims as shown below.

1. (Currently amended) A solid-state image pickup device characterized by comprising:

an imaging area including multiple two-dimensionally arranged pixels,

wherein the pixel has a collective lens and a photoelectric converting portion;

the photoelectric converting portion has a surface in an asymmetrical form;

the collective lens is positioned above the photoelectric converting portion and at a substantial symmetrical center making up for the surface asymmetry in a pixel in a center part of the imaging area;

the collective lens is placed at a position shifted more toward the center of the imaging area from a part on the symmetrical substantial center as a distance from the center of the imaging area to a pixel thereof increases; and

the collective lens has an amount of the shift depending on the degree of asymmetry of the surface of the photoelectric converting portion in a pixel positioned in at an equal distance from the center of the imaging area.

2. (Currently amended) A-The solid-state image pickup device according to Claim 1, characterized in that the surface of the photoelectric converting portion has a rectangular form missing at least one corner; and

the collective lens is positioned at a substantial center of the rectangular form in a pixel in the center part of the imaging area.

3. (Currently amended) A solid-state image pickup device characterized by comprising: an imaging area including multiple two-dimensionally arranged pixels,

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wherein the each pixel has a collective lens and a photoelectric converting portion;

the collective lens is placed at a position shifted more toward the center of the imaging area as a distance from the center of the imaging area to a pixel thereof increases; and

an amount of the shift of the collective lens is defined based on the height from a surface of the photoelectric converting portion of the collective lens and the thickness in the direction of depth of the substrate of the photoelectric converting portion such that an amount of light incident within the photoelectric converting portion can increase.

4. (Currently amended) A-<u>The</u> solid-state image pickup device according to Claim 3, characterized in that:

the photoelectric converting portion is inclined to a predetermined side within a pixel, and the collective lens has an amount of shift depending on an the amount of an inclination of the position of the photoelectric converting portion within each of pixels having an equal distance from the center of the imaging area.

- 5. (Currently amended) A-The solid-state image pickup device according to Claim 3, characterized in that the each pixel further has multiple wires provided through an insulating film, and the wires are placed at a position shifted toward the center of the imaging area like the collective lens.
- 6. (Currently amended) A-The solid-state image pickup device according to Claim 3, characterized in that a bottom of the photoelectric converting portion is placed at a position shifted from the center of the imaging area toward the outside with respect to the surface thereof.

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7. (Currently amended) A-The solid-state image pickup device according to Claim 6, characterized in that an amount of the shift of the bottom of the photoelectric converting portion is

increased as the distance from the center of the imaging area to a pixel thereof increases.

8. (Currently amended) A-The solid-state image pickup device according to Claim 3,

characterized in that the photoelectric converting portion includes an impurity region formed by

performing ion-implantation into a semiconductor layer multiple times.

9. (Currently amended) A solid-state image pickup device, characterized by

comprising:

an imaging area including multiple two-dimensionally arranged pixels,

wherein the each pixel has a photoelectric converting portion, and;

a bottom of the photoelectric converting portion is placed at a position shifted from the

center of the imaging area toward the outside with respect to the surface thereof in each of at least

partial some pixels of the multiple pixels.

10. (Currently amended) A-The solid-state image pickup device according to Claim 9,

characterized in that an amount of the shift of the bottom of the photoelectric converting portion is

increased as the distance from the center part of the imaging area to a pixel thereof increases.

11. (Currently amended) A-The solid-state image pickup device according to Claim 9,

characterized in that the photoelectric converting portion includes an impurity region formed by

performing ion-implantation into a semiconductor layer multiple times.

12. (Currently amended) A-The solid-state image pickup device according to Claim 11,

characterized in that the impurity region is formed by performing ion implantation multiple times at

different angles of implantation.

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13. (Original) An electronic apparatus having a solid-state image pickup device, the

apparatus characterized in that:

the solid-state image pickup device has:

an imaging area including multiple two-dimensionally arranged pixels;

the pixel has a collective lens and a photoelectric converting portion;

the collective lens is placed at a position shifted more toward the center of the imaging area

as a distance from the center of the imaging area to a pixel thereof increases;

an amount of the shift of the collective lens is defined based on the height from a surface of

the photoelectric converting portion of the collective lens and the thickness in the direction of depth

of the substrate of the photoelectric converting portion; and

a bottom of the photoelectric converting portion is shifted from the center of the imaging

area toward the outside with respect to the surface thereof.

14. (Original) A method of manufacturing a solid-state image pickup device,

characterized by comprising:

a step of forming a photoelectric converting portion and collective lens in each pixel of an

imaging area,

wherein the collective lens is placed at a position shifted more toward the center part of the

imaging area as a distance from the center of the imaging area to a pixel thereof increases; and

an amount of the shift of the collective lens is defined based on the height from a surface of

the photoelectric converting portion of the collective lens and the thickness in the direction of depth

of the substrate of the photoelectric converting portion such that an amount of light incident within

the photoelectric converting portion can increase.

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15. (Currently amended) A-The method of manufacturing a solid-state image pickup device according to Claim 14, characterized in that a bottom of the photoelectric converting portion is placed at a position shifted from the center part of the imaging area toward the outside with respect to the surface thereof.

- 16. (Currently amended) A-The method of manufacturing a solid-state image pickup device according to Claim 15, characterized in that an amount of the shift of the bottom of the photoelectric converting portion is increased as the distance from the center of the imaging area to a pixel thereof increases.
- 17. (Currently amended) A-The method of manufacturing a solid-state image pickup device according to Claim 16, characterized in that the photoelectric converting portion is formed by performing ion-implantation into a semiconductor layer multiple times.
- 18. (Currently amended) A-The method of manufacturing a solid-state image pickup device according to Claim 17, characterized in that the ion-implantation is performed multiple times at different angles of implantation.